



System				
ZYGO P/N	6306-0360-04 system with full enclosu	ıre		
	6306-0360-05 system with 1/2 height enclosure			
Measurement Technique	3D coherence scanning interferometry, SureScan™ technology			
Scanner	Precision Piezo drive with Closed loop capacitance gauge control and crash protection			
Objectives	1.0X – 100X magnification; Standard and long working distance; See the Nexview & NewView 9000 Series Objective Chart for more details	5		
Objective Mounting Options	<ul><li>Single objective dovetail</li><li>Manual Encoded 4-position turret</li><li>Motorized 4-position turret</li></ul>			
Optical Zoom	Motorized 3-position encoded zoom • 0.5X, 1.0X, 2.0X included • 0.75X, 1.5X optional			
Field of View	Objective and zoom selectable from $0.04 \times 0.04$ mm to $17.49 \times 17.49$ mm; Integrated field stitching for larger areas	;		
Illuminator	Proprietary solid-state white light source with software-selectable field stop, aperture stop and spectral filters			
Measurement Array	Selectable 1600 x 1200, 1000 x 1000, 1000 x 600, 1000 x 200			
Part Viewing	Selectable Monochrome imaging with available fringe-free viewing mode			
Focus	Motorized manual or auto focus with Part Finder and Smart Setup Technology	t		
Z-Drive (Focus) Stage	150 mm range with 0.1 μm resolution			
Part Stage	Encoded linear motor drive with $650 \times 650$ mm XY travel range			
Stage Configuration	Split axis gantry style; X-stage translates Head; Y-stage translates the sample	S		
Sample Holder	Custom vacuum sample holders up to			

650 x 650 mm available

Windows 10 (64-bit)

166 x 140 x 164 cm

System: 1830 kg

System with enclosure:

100 to 240 VAC, 50/60 Hz

filtered; 1/4 in. input

i7 class PC with 1080P display

System with enclosure: 1955 kg

4.1 to 5.5 bar (60 to 80 psi); dry and

Optional from a customer supplied source,

ZYGO Mx software running under Microsoft

Performance  Vertical Scan Range  Surface Topography Repeatability (1)  Repeatability of RMS(2)  Performance  150 μm with precision Piezo drive; 20 mm with extended scan  0.12 nm  0.01 nm				
Surface Topography Repeatability <sup>(1)</sup> 0.12 nm				
Repeatability <sup>(i)</sup> 0.12 nm				
Repeatability of RMS <sup>(2)</sup> 0.01 nm				
Optical Lateral Resolution <sup>(3)</sup> 0.34 µm (100X objective)				
Spatial Sampling 0.04 µm (100X objective 2X zoom)				
Maximum Data Scan Speed <sup>(4)</sup> 53 μm/sec @ 1600 x 1200 69 μm/sec @ 1000 x 1000 107 μm/sec @ 1000 x 600 171 μm/sec @ 1000 x 200				
Step Height Repeatability <sup>(5)</sup> 0.1%				
Step Height Accuracy <sup>(6)</sup> 0.3%				
TEST PART CHARACTERISTICS				
Material Opaque, transparent, coated, uncoated, specular, rough				
Maximum 260 mm under X axis Crossbeam 329 mm under typ. objective focus				
Maximum 55° – smooth part @ 100X Surface Slope 85° – scattering surface				
Sample Reflectivity 0.05% - 100%				

## **ENVIRONMENTAL REQUIREMENTS**

INOMPENTAL REQUIREMENTS			
Temperature	15 to 30°C with rate of change <1.0°C per 15 min		
Humidity	5 to 95% relative, noncondensing		
Vibration Isolation	Included and required for vibration in the range of 1 Hz to 120 Hz		
Vibration Criterion	VC-C or better		
Acoustic Criterion	NC30 or better		

## **FOOTNOTES**

Performance specifications under laboratory conditions using standard specimens, according to ISO 25178-601, 25178-604 and 5436-1.

- (1) Surface Topography Repeatability for CSI mode, 1-sec acquisition, full FOV with 3x3 median filter, in a laboratory environment.
- (2) Repeatability of the RMS surface roughness parameter Sq, under the same conditions as for (1). Note that the repeatability of the Sq is sometimes referred to informally as "vertical resolution."
- (3) Lateral Resolution=Sparrow criterion, objective dependent.
- (4) Data scan speed depends on the measurement array and data acquisition mode.
- (5)  $1-\sigma$  Step height repeatability verified using 1.8  $\mu$ m and 24  $\mu$ m ZYGO certified step height standards.
- (6) Instrument contribution to uncertainty for step height measurements using the piezo drive.





System

Controller

Software

Dimensions

(HWD)

Weight

**UTILITY REQUIREMENTS** 

Vacuum

Input Voltage

Compressed Air for isolation

**PHYSICAL** 





